

Agilent

MIPI D-PHY Protocol Test Solutions

N4851A/B MIPI D-PHY Acquisition Probe

N4861A/B MIPI D-PHY Stimulus Probe

Data Sheet

- Accelerate your MIPI D-PHY test development
- Simplify your MIPI D-PHY test environment by combining stimulus and analysis



Applications

- MIPI D-PHY hardware prototype turn-on and debug
- System integration of embedded controller with MIPI D-PHY display and camera devices
- Troubleshooting interoperability issues
- Robustness test with error injection
- Software debug of MIPI D-PHY-based systems

Key features

- Combined MIPI D-PHY real-time analysis and stimulus test solution
- Real-time trace of MIPI D-PHY bus modes
- Decoding and visualization of CSI-2 and DSI protocols
- Easy trigger setup with predefined pattern library
- Hierarchical trace display capabilities
- Automatic stimulus generation from bitmap picture
- Full custom traffic generation
- Capture and replay capabilities
- Link layer test with parametric control of voltages and timing
- Based on a modular, scalable, logic analyzer platform for multi-bus, system-level measurements
- Multilevel trigger sequencer to trigger the analyzer on complex event conditions



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N4851A/B and N4861A/B MIPI D-PHY Analysis and Stimulus Test

Combine custom traffic generation and real-time analysis to diagnose and characterize your system faster



MIPI D-PHY is a packet-based interconnect standard defined for use in wireless mobile devices as the communication bus between the main components such as the embedded controller (BB-IC) and cameras and displays.

When you adopt the MIPI D-PHY standard in your designs, you will face new test challenges during the debug, integration and system validation phases of the development process.

To ensure your design operates according to the MIPI D-PHY link and CSI-2 or DSI protocol specification, you need real-time insight on the DUT's behavior at various protocol levels, and you need to be able to trigger on protocol-specific patterns or error conditions.

To reproduce system problems or run non-regression tests, you often need to create traffic conditions that may be difficult to reproduce with real devices. The MIPI D-PHY stimulus solution can accelerate your design/debug/test cycle by reproducing these conditions.

The specific nature and operation modes of the MIPI D-PHY serial interconnect makes it extremely difficult to analyze or to stimulate with general-purpose test instruments.

Now you can get the capabilities you need with the N4851A/B and N4861A/B analysis and stimulus solution.

The Agilent Technologies N4851A/B acquisition probe and the N4861A/B stimulus probe operate in conjunction with Agilent 16800 and 16900 Series logic analyzers to provide the digital serial stimulus and acquisition capabilities required to independently debug and test a MIPI D-PHY component, or integrate your MIPI D-PHY-based mobile designs.

Thanks to the modular and scalable architecture of Agilent 16800 and 16900 logic analyzers, the MIPI D-PHY analysis and stimulus measurements can be time-correlated with other measurements (control logic, other serial buses, memory) on the device under test, helping you perform system-level measurements.

Cross triggering capabilities help you observe the activity on a bus when a specific event happens on another bus, helping you find the root cause of complex system-level problems.

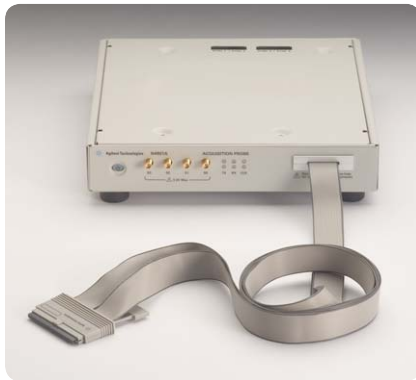
With this versatile architecture, you can use the same platform from the bus design phase to system-level test, so you reduce your expenditure on test equipment.

This common, scalable system for protocol analysis and traffic generation protects your financial investment for years to come.

Typical Configurations

MIPI D-PHY analysis configuration

- In analysis-only mode, the N4851A/B transparently captures traffic between two devices.
- Link activity and protocol operation (CSI, DSI) is captured through various probing solutions, from flying leads to soft-touch connectors.
- The analyzer includes a multilevel sequencer to trigger the analyzer on complex event conditions.
- Multiple analyzers can be synchronized and cross triggered for system-level measurements.



N4851A/B MIPI D-PHY acquisition probe

MIPI D-PHY stimulus and analysis solution

- In active test mode (stimulus + analysis), a customizable stimulus is sent to the DUT, with simultaneous analysis of the response.
- The stimulus solution can be used to test peripherals, such as display devices, by simulating a system controller.
- Stimulus patterns can be defined in multiple ways:
 - File-based stimulus
 - GUI-based stimulus
 - Record and play pattern
 - Bitmap-based Stimulus



N4861A/B MIPI D-PHY stimulus probe



Flying leads signal probing solution



Soft touch connectorless probes reduce cost and shorten your design cycle by eliminating probing connectors

N4851A/B Protocol Analysis Gives You Fast Insight into Your System

Flexible GUI gives you easy visibility into MIPI D-PHY activity and system operation

- Bus mode operation, CSI-2 and DSI traffic, and trigger status are simultaneously displayed

Hierarchical trace display speeds your debug process

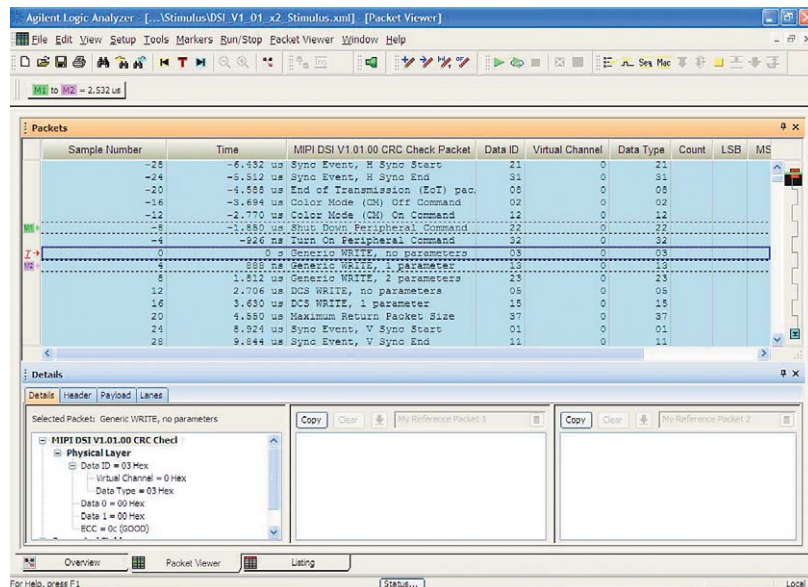
- Avoid constant scrollings with the hierarchical display that maximizes information density on the screen
- DSI and CSI-2 decoding capabilities for camera and display traffic analysis
- Compare frames details and easily find bit-level differences
- Easily retrieve information with embedded markers
- Quickly find problems with automatic error detection

Powerful triggering, easy setup

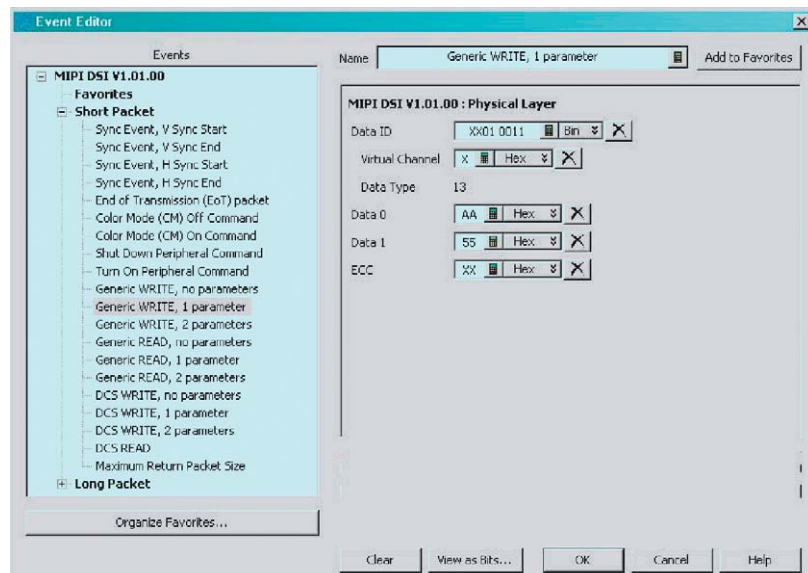
- Easy trigger setup by using and editing predefined patterns from the pattern library

Multi-bus display for better insight into your system

- Traces captured from multiple buses are displayed with time-correlated time-stamps and common markers
- Multiple analyzers can share events for sophisticated cross triggering



MIPI D-PHY packet viewer



Trigger window

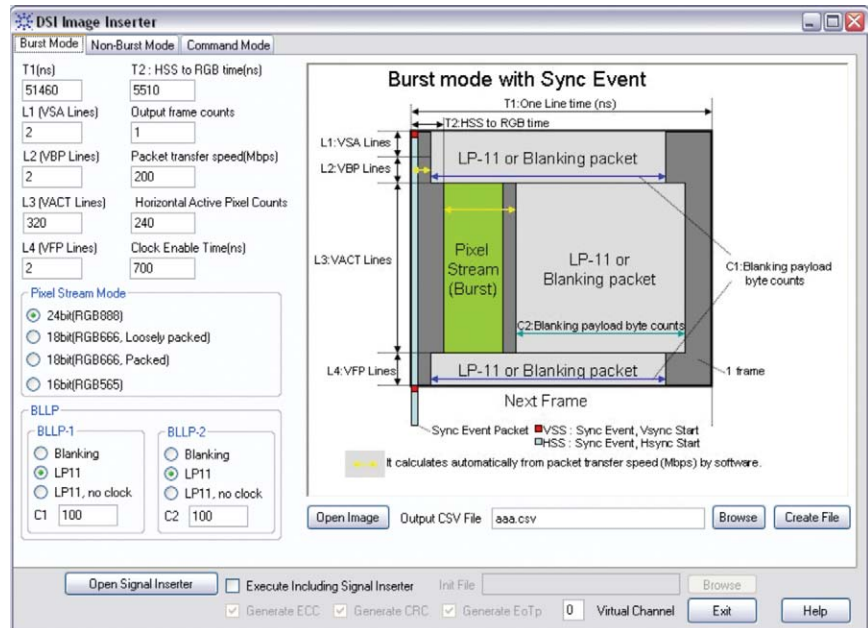
Image Inserter and Image Extractor Applications

Quickly build MIPI DSI stimulus from bitmap files with the Image Inserter application

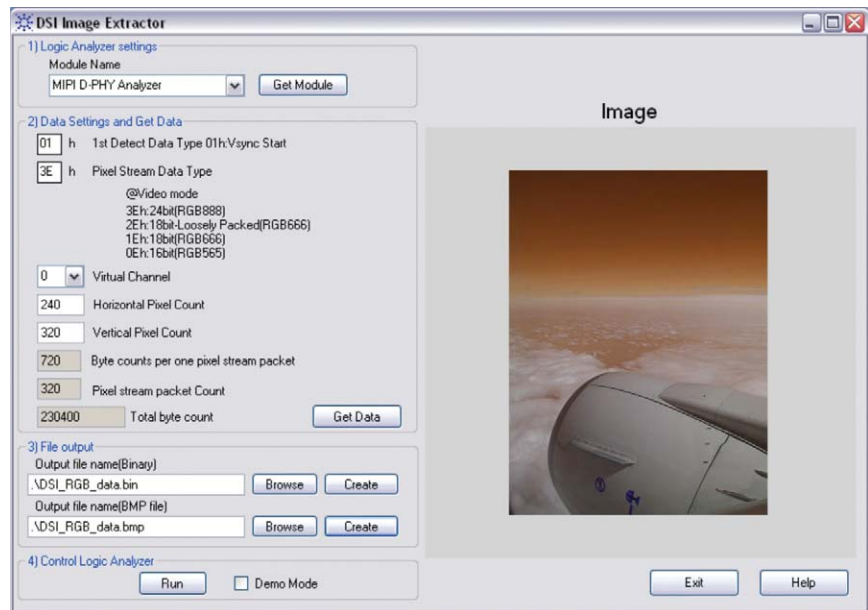
- Save hours of development and editing
- Configurable formats, bitmap encoding
- Multiframe generation
- Virtual channel support
- Supports burst mode, non-burst mode, command mode
- Supports initialization commands

Visualize bitmaps from real time trace files with the Image Extractor application

- Reconstruct picture from DSI trace
- Virtual channel support
- Multiple frame support



DSI Image Inserter



DSI Image Extractor

Agilent N4851A/B Analysis Probe – Features and Specifications

Electrical characteristics

Voltage level support	D-PHY compliant
LPVhigh	800 mV to 3.3 V
Voltage sensitivity	100 mV typical
Track changes in speed mode	Yes - Mode changes displayed on trace
Termination	Analyzer probe snoops the bus (is not an endpoint on the bus) Termination is dependent on the actual endpoint device
Lane width	2 channels (N4851A), 4 channels (N4851B)
Maximum bit rate (high-speed mode)	800 Mbps (N4851A), 940 Mbps (N4851B)
Minimum bit rate (high-speed mode)	80 Mbps, per D-PHY specification
Maximum bit rate (low-power mode)	10 Mbps, per D-PHY specification
Minimum bit rate (low-power mode)	N/A (no specification)
Protocol version support and decoding	
MIPI D-PHY DSI 1.01	Yes
MIPI D-PHY DSI 1.00	No
MIPI D-PHY CSI-2 1.00	Yes

Protocol viewing

Protocol viewer	Hierarchical packet-level display
Protocol decoder	
HS and LP data support	Yes
Short and long packet decode	Yes
CSI and DSI decode	Yes
Decode speed changes	Yes
Payload viewing	Yes
Error decode	
SOT error display	Yes
EOT error display	Yes
Escape error display	Yes
Sequence error display	Yes
Turnaround error display	Yes
ECC, CRC error display	Yes
Contention detection	No

Agilent N4851A/B Analysis Probe – Features and Specifications (continued)

Triggering capabilities

Trigger on protocol patterns	Yes, on both DSI and CSI long and short patterns
Protocol pattern customization	Yes, with bit-level editing
Real-time error detection	
SOT error trigger	Yes, on a per lane basis
EOT error trigger	Yes, on a per lane basis
Escape error trigger	Yes, on a per lane basis
Sequence error trigger	Yes, on a per lane basis
Turnaround error trigger	Yes, on a per lane basis

Display

Low power state of data transmission	Yes
Ultra-low power state	Not visible in the trace
Stopped	Yes

N4861A/B Stimulus Probe Helps You Characterize Your System's Operation under Multiple Traffic Conditions

Increase test coverage with configurable traffic generation

- Configurable traffic can be generated from the GUI, or from CSV files and bitmap files
- Deterministic D-PHY, DSI, CSI-2 pattern generation
- Customize the initialization sequence independently from the main test sequence
- Repetitive events
- 1, 2 or 3 channels support
- Stimulus up to 1 Gbps

Test your device's link layer and protocol layer

- Custom D-PHY bus mode transitions and link event generation
- Test low-power bus mode
- Custom DSI, CSI-2 traffic generation

Validate boundary conditions of your devices and components

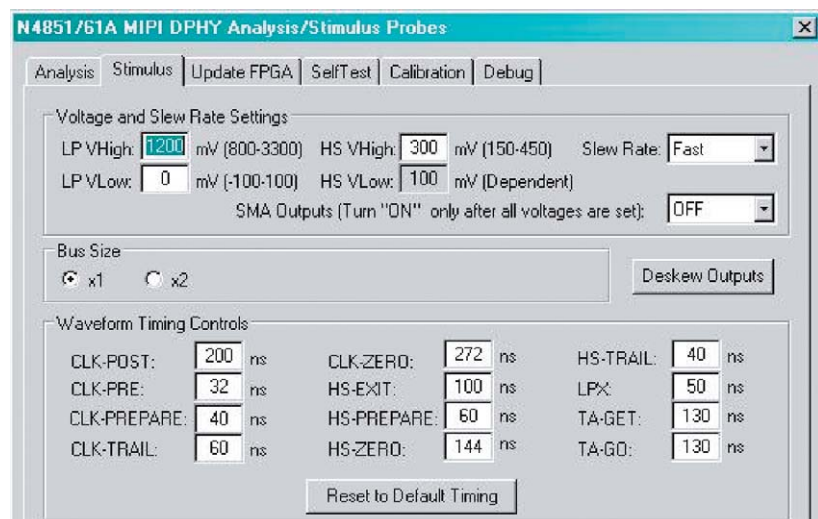
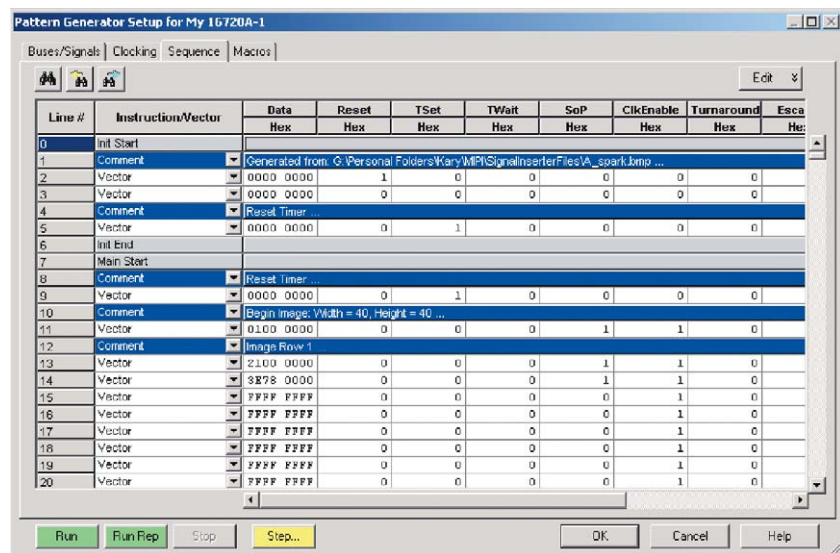
- Timing control of MIPI D-PHY link layer events within or outside specifications
- Voltage control of MIPI D-PHY signals
- Manual control of error generation helps you test robustness and error recovery mechanisms

Record and play capabilities help you reproduce test scenarios from captured traces

- Use a wide range of specific real-world traffic conditions
- Save trace captured on a real target and replay it as many times as you want

Increase test coverage with configurable traffic generation

- Generate traffic for multiple ports and correlate the test results across time for comprehensive system testing



Timing and voltage control of MIPI D-PHY stimulus

Agilent N4861A/B Stimulus Probe – Features and Specifications

Electrical characteristics	LSR features
Lane width	2 channels (N4861A), 3 channels (N4861B)
Voltage level support	D-PHY compliant
Low-power voltage high adjustment	800 mV → 3.3 V
Low-power voltage low adjustment	–100 mV → +100 mV
High-speed voltage high adjustment	+150 mV → +450 mV
High-speed voltage low adjustment	Not adjusted independently (changes with LPVlow or HSVhigh) Range is –17 mV to 217 mV
Slew rate control	Meets D-PHY specification in fast mode Fast, medium, slow, slowest
Mode change support	Yes
Waveform timing control	
CLK-POST timing control	Yes, automatic or manual settings
CLK-PRE timing control	Yes, automatic or manual settings
CLK-PREPARE timing control	Yes, automatic or manual settings
CLK-TRAIL timing control	Yes, automatic or manual settings
CLK-ZERO timing control	Yes, automatic or manual settings
HS-EXIT timing control	Yes, automatic or manual settings
HS-PREPARE	Yes, automatic or manual settings
HS-Zero	Yes, automatic or manual settings
HS-TRAIL	Yes, automatic or manual settings
LPX	Yes, automatic or manual settings
TA_Get	Yes, automatic or manual settings
TA_GO	Yes, automatic or manual settings
CLK lane and data lane skew adjust	No, under investigation
Device under test termination	
Expected DUT HS termination	100-ohm differential termination
Expected DUT LP termination	None
Stimulus probe termination (no termination switching provided)	Either driver or tri-state (master only)
Clock input	Required for stimulus probe operation
Data rate below 200 Mbps	Clock input = 1/2 bit rate
Data rate at or above 200 Mbps	Clock input = 1/10 bit rate

Agilent N4861A/B Stimulus Probe – Features and Specifications (continued)

Performance – the numbers below are guaranteed to comply to D-PHY's specifications

Maximum bit rate (high-speed mode)	500 Mbps (N4861A), 1 Gbps (N4861B)
Minimum bit rate (high-speed mode)	80 Mbps (per the D-PHY specification)
Maximum bit rate (low-power mode)	10 Mbps (per the D-PHY specification)
Minimum bit rate (low-power mode)	800 Kbps (based on timers)
Version support MIPI D-PHY 0.89 , 0.90, 1.00	Complete, except support for slave mode operation. Only operates as a master on the bus
Probe not limited to CSI or DSI, supports D-PHY	

Stimulus

Features

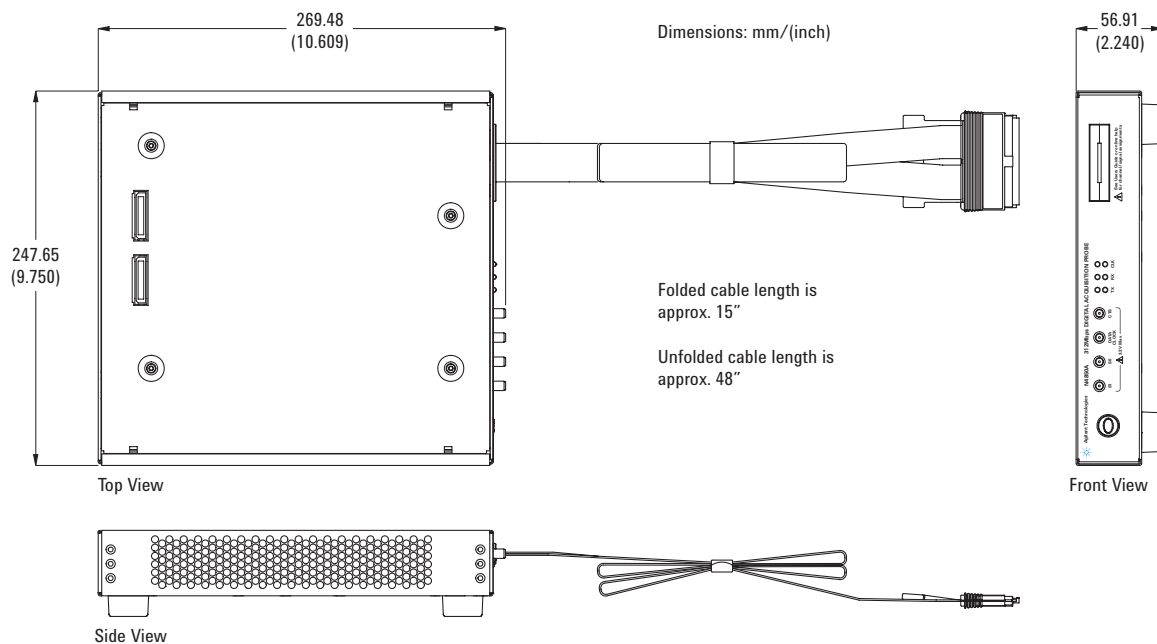
Packet generation	Yes
ECC/CRC automatic calculation	Yes, done by software
DSI video modes	Burst mode, non-burst mode, command mode

Error injection

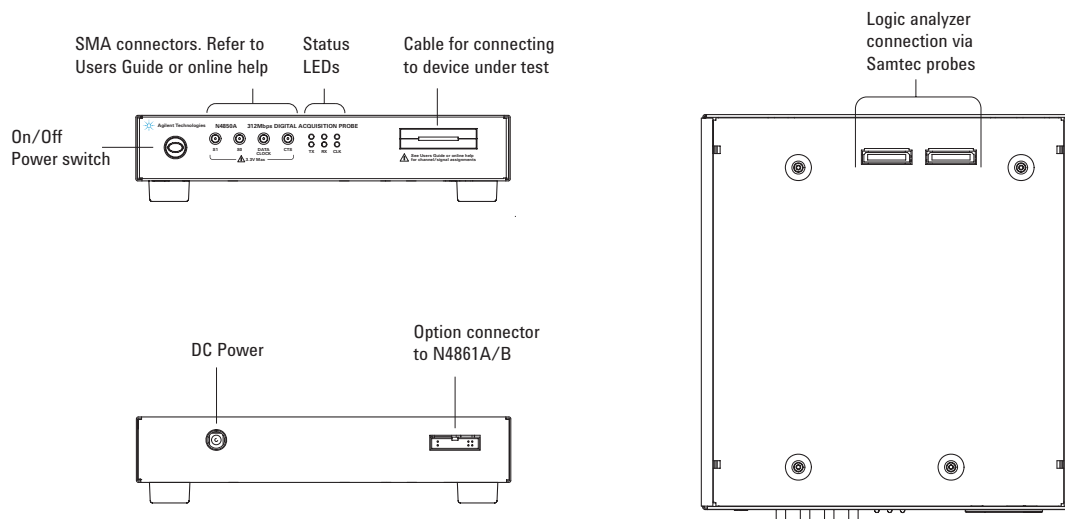
HSDT request error generation	Yes, with timing control to violate specs
SOT synch error generation	No
Endof HSDT error generation	Yes, with timing control to violate specs
LPD transmission error generation	Yes, with waveform timing control and direct control of data transmitted on the link
Protocol errors	Yes
Turnaround error generation	No (does not operate in slave mode)
ECC, CRC error generation	Manual

N4851A/B and N4861A/B Physical Characteristics

Dimensions



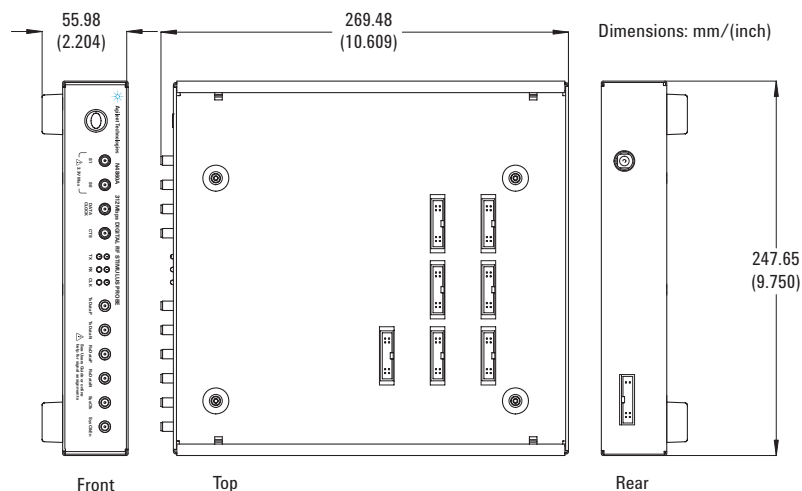
N4851A/B exterior dimensions



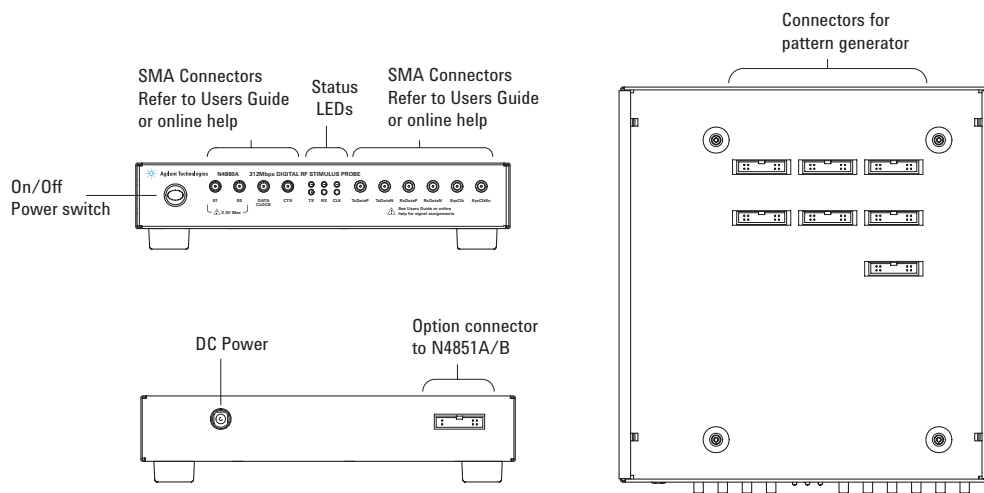
N4851A/B front panel, rear panel and top view

N4851A/B and N4861A/B Physical Characteristics (continued)

Dimensions



N4861A/B exterior dimensions



N4861A/B front panel, rear panel, and top view

Ordering Information

When you configure your MIPI D-PHY measurement system, consider the following:

Ability to provide MIPI D-PHY stimulus

- For comprehensive stimulus and response testing of your MIPI D-PHY device or system, select a logic analyzer with digital pattern generation capability (16822A, 16823A, or a 16900 modular logic analysis system with a 16720A pattern generator module).

Flexibility to grow as your measurement needs evolve:

- A modular 16900 Series logic analyzer addresses your measurement needs today and allows you to grow as your needs evolve.

Modification of the logic analyzer's MIPI D-PHY protocol decoder

- The MIPI D-PHY standard provides the flexibility to customize your control structure and data packets for your specific application. With the B4641A protocol development kit, you can modify the logic analyzer's MIPI D-PHY protocol decoder to track your custom solution.

DUT requirements for use with N4861A/B stimulus probe:

- SMA (m-m) connectors on the target. The number of SMA connectors depends on your test scenario: turn on, validation, or system integration.

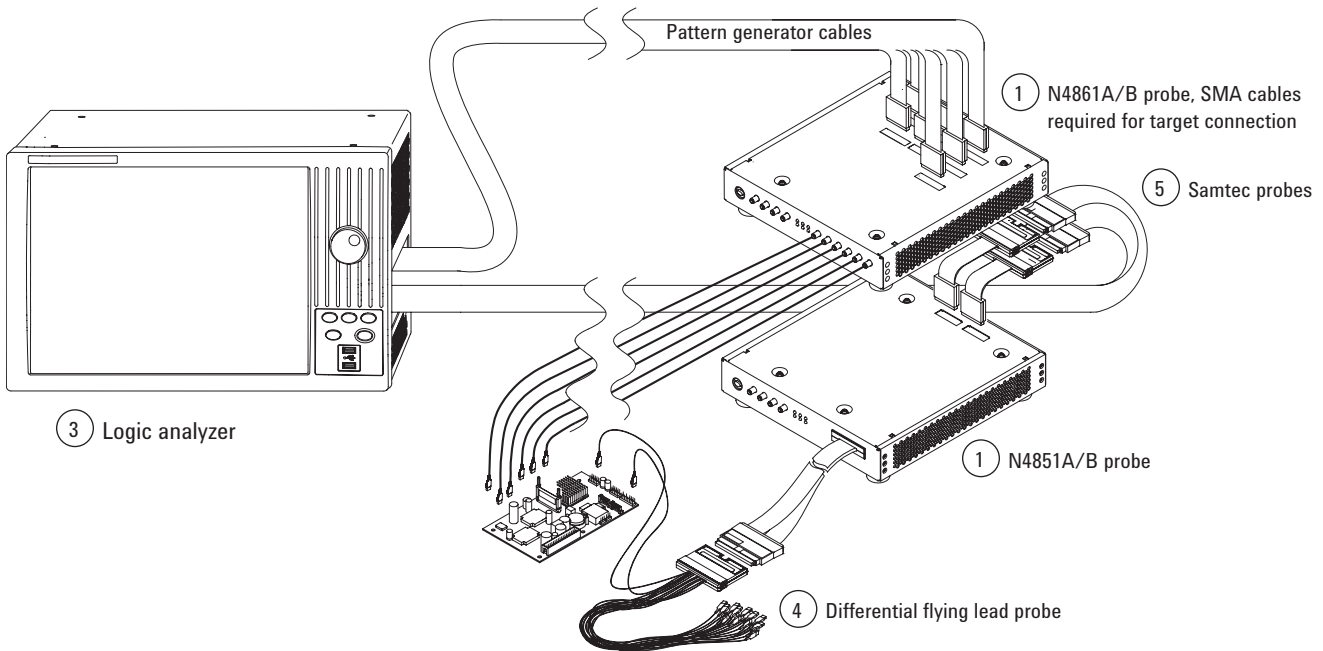
N4851U upgrade kit

If you own an N4851A MIPI D-PHY analysis probe or an N4861A MIPI D-PHY stimulus probe, the N4851U upgrade kit will extend the capabilities of your test system:

- With the N4851U-004, your N4851A analysis probe can support up to 4 lanes.
- With the N4851U-004, your N4861A stimulus probe will support up to 3 lanes.
- One N4851U-004 is required for each logic analyzer connected to MIPI D-PHY analysis and stimulus probes.

Ordering Information: Analysis and Stimulus Solution

To configure a complete MIPI D-PHY digital acquisition and stimulus system, you will need to order or have the following items:



MIPI D-PHY digital acquisition and stimulus system

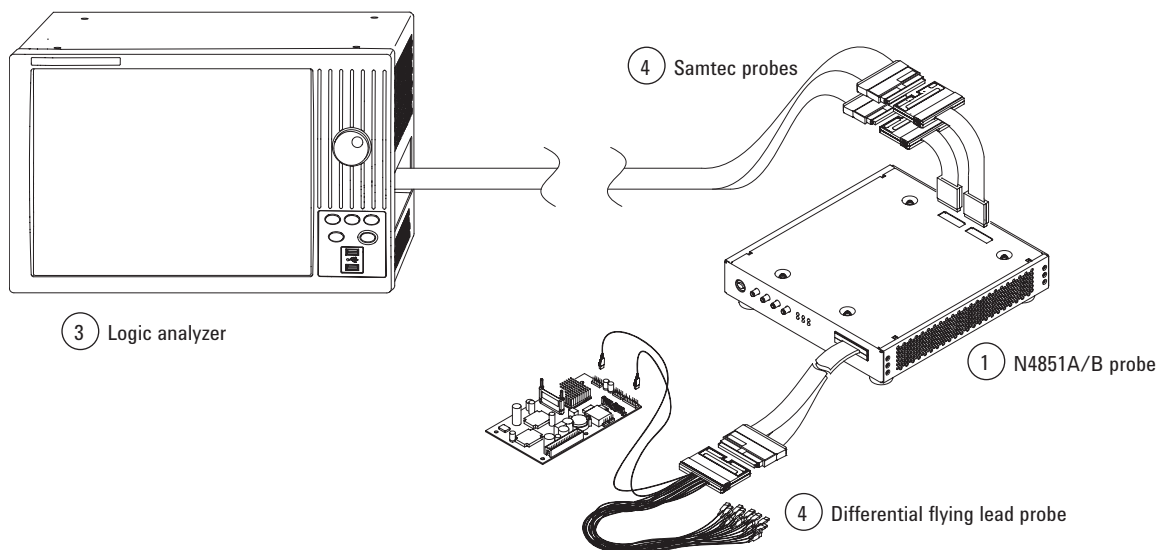
			Probes between the N4851A/B and the...	
1. MIPI D-PHY probes	2. Method to create data	3. Logic analyzer with 48-channel pattern generator ²	4. Device under test (One of the following for each N4851A/B)	5. Logic analyzer (Two Samtec probes per N4851A/B – one for Tx and one for Rx. Select probe that is compatible with your logic analyzer.)
N4861A or N4861B¹ digital stimulus probe <ul style="list-style-type: none"> N4861A-040: Two sets of four 40-inch SMA cables 	<ul style="list-style-type: none"> Convert captured logic analyzer trace to stimulus Custom programmatic generation 	16800 Series portables <ul style="list-style-type: none"> 16822A – 68 ch 16823A – 102 ch 16900 Series modular mainframe with at least one each of the following: <ul style="list-style-type: none"> 16900 Series module(s) 16720A pattern generator module 	<ul style="list-style-type: none"> E5381A differential flying lead probe E5405A differential pro series soft touch probe E5387A differential soft touch probe 	<ul style="list-style-type: none"> E5385A for logic analyzers with a 40-pin cable connection (16822A, 16823A, 16910/11A) E5378A for logic analyzers with a 90-pin cable connection (1695X modules)
N4851A digital acquisition probe <ul style="list-style-type: none"> -010 for node-locked license -020 for floating (server) license 				
N4851B digital acquisition probe				

1. N4861A/B digital stimulus probe requires an N4851A/B digital acquisition probe to operate and a clock generator, such as the Agilent 33250A.

2. Compatible with 16800 or 16900 Series logic analyzers with 68 channels or more.

Ordering Information: Analysis Solution

To configure a complete MIPI D-PHY digital acquisition system, you will need to order or have the following items:



MIPI D-PHY digital acquisition system

		Probes between the N4851A/B and the...	
1. MIPI probes (One per Tx/Rx pair)	2. Logic analyzer ¹	3. Device under test (One of the following for each N4851A/B)	4. Logic analyzer (Two Samtec probes per N4851A/B – one for Tx and one for Rx. Select probe that is compatible with your logic analyzer)
N4851A digital acquisition probe	16800 Series portables	• E5381A differential flying lead probe	• E5385A Samtec probe for logic analyzers with a 40-pin cable connection (16800 Series, 16910/11A)
• -010 for node-locked license	• 16802A – 68 ch	• E5405A differential pro series soft touch probe	• E5378A Samtec probe for logic analyzers with a 90-pin cable connection (1695X modules)
• -020 for floating (server) license	• 16803A – 102 ch	• E5387A differential soft touch probe	
N4851B digital acquisition probe	• 16804A – 136 ch		
	• 16806A – 204 ch		
	• 16822A – 68 ch		
	• 16823A – 102 ch		
	16900 Series modular mainframe with at least one 16900 Series module		

1. Compatible with 16800 or 16900 Series logic analyzers with 68 channels or more



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Product Web site

For the most up-to-date and complete application and product information, please visit our product Web site at:

www.agilent.com/find/MIPI

Related Agilent literature

Publication title	Pub number
<i>Agilent 16800 Series Portable Logic Analyzers Data Sheet</i>	5989-5063EN
<i>Agilent 16900 Series Logic Analysis Mainframes Data Sheet</i>	5989-0421EN
<i>Probing Solutions for Agilent Technologies Logic Analyzers Catalog</i>	5968-4632E

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